Searcn Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/975,910	CHEN ET AL.	
Examiner	Art Unit	
Jung Park	2661	

SEARCHED			
Class	Subclass	Date	Examiner
		-	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	e Search - ry Printout	1/10/2006	JP

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	DATE	EXMR
Consulted with Chau Nguyen 370/331, 338, 401; 455/436, 442 (text search only - see history printout)	1/5/2005	JP